# OPTIMIZATION OF LOW POWER ADDER CELLS USING 180NM TG TECHNOLOGY

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#### **ABSTRACT**

Continuous scaling of the transistor size and reduction of the operating voltage has led to a significant performance improvement of integrated circuits. Low power consumption and smaller area are some of the most important criterion for the fabrication of Digital Signal Processing (DSP) systems and high performance systems like Laptop & Android based applications in order to achieve the best performance with minimized power consumption. In this paper, Power Dissipation, Transistor Count and Propagation Delay have been minimized as the length and width of NMOS and PMOS are optimized. The proposed circuits are designed and optimized using the Transmission Gate (TG) technology, and the comparative analysis of TG based 8-bit adders has been carried out with 180nm technology, using TANNER EDA tool.

Keywords - Carry Bypass Adder, Carry Look-Ahead Adder, GPDK 180 Nm, Ripple Carry Adder, TG Based CMOS Logic Design Style.

# I. INTRODUCTION

The adder is the most commonly used arithmetic block of the Central Processing Unit (CPU) and Digital Signal Processor (DSP), therefore its performance and power optimization is of utmost importance. With the technology scaling to deep sub-micron, the speed of the circuit increases rapidly. At the same time, due to the increasing chip density, the power consumption per chip also increases. Therefore, in realization of the modern Very Large Scale Integration (VLSI) circuits, lower power consumption and higher speed are the two predominant factors which need to be considered. Like any other circuit's design, the design of high-performance and low- Power adders can be addressed at different levels, such as logic style, architecture, process technology and the layout. In the proposed paper, Power dissipation, Transistor count and Propagation Delay have been minimized by optimizing the length and width of NMOS and PMOS transistors. Saradindu et al. [1] initiated the research work by proposing a full adder built by 28 transistors. As the transistor count is very high, the average power consumption, leakage power consumption and delay is very high. By making the advanced full adder circuit, the transistor count, power consumption and propagation delay of the circuit has been reduced. By applying the different threshold voltages, the power and delay of the new full adder circuit has been optimized. Further enhancement took place when Vladimir [2] invented a new method for analysis and comparison of ripple carry full adders by speed on the basis of a new criterion "equal delay capacity" is done. The proposed method allows quickly and exactly comparing various one-bit adders cell designs by speed for the specific application in devices. Radu et al. [3] introduced another new methodology for energy-delay optimization of digital circuits.

This methodology is applied for minimizing the delay of representative carry-look ahead adders under energy constraints. The optimality of the result is assessed against the impact of technology scaling. By analyzing the impact of the main design choices on adder behavior in the energy-delay space, a set of guidelines can be established to guide the designer when choosing the architecture of a 64-bit adder. Dan et al. [4] proposed four low power adder cells used with different XOR and XNOR gate architectures. Basically, two sets of circuit designs has been presented. One implements full adders with 3 transistors (3-T) XOR and XNOR gates and the other uses the Gate-diffusion-input (GDI) technique to the full adders. Simulations are run by using H spice based on 180nm CMOS technology. On the other hand, in comparison with static energy recovery full (SERF) adder cell module, the four full adder cells demonstrate their advantages, including lower power consumption, higher speed and smaller area. On the other hand, Sreehari and M.B. Srinivas [5] invented three new 1-bit full adder cells having a delay of 2T using the existing 3-T XOR and XNOR gates. The power dissipation, delay, power-delay product and area of these adders have been compared with the existing adders and are found to be efficient. Reza et al. [6] proposed the introduction of two novel 1-bit full adder cells in dynamic logic styles . NP-CMOS (Zipper) and multi-Output structures are used to design the adder blocks. Characteristics of dynamic logic lead to higher speeds than the other standard static full adder cells. Using H-Spice and 0.18µm CMOS technology exhibits a significant decrease in the cell delay which results in a considerable reduction in the power-delay product (PDP). Massimo and Gaetano [7] proposed the main topologies of one-bit full adders which have been compared for speed, power consumption, and power-delay product. The comparison has been performed on two classes of circuits, the former with minimum transistor size to minimize power consumption, the latter with optimized transistor dimension to minimize power-delay product. It reveals that except for short chains of blocks or for cases where minimum power consumption is desired, topologies with only pass transistors or transmission gates are not attractive. While Sumeer et al. [8] proposed the designs for 1-bit full adder cell featuring hybrid CMOS logic style. These designs were based on a novel XOR-XNOR circuit that simultaneously produces XOR and XNOR full-swing outputs and outperforms its best counterpart showing 39% improvement in PDP. The new XOR-XNOR circuit displays superior performance as compared to the best competitor. The improvement in terms of PDP obtained by the best full-adder cell as compared to the best standard design, amounts to 24%. Further implementations in this work was carried out by S. Wairya et al. [9] in which a novel design to realize full adder circuit was implemented. Basically, the approach was based on OR-XNOR design full adder circuits in a single unit. Objective of this work was to investigate the power, delay and power delay product of low voltage full adder cells in different CMOS logic styles. Simulation results, depicts the superiority of the proposed adder circuit against the conventional CMOS, Hybrid, Bridge, XOR-XNOR adder circuits in terms of average power consumption, propagation delay and PDP. The design was implemented on GPDK 90 nm technology, processing models in Cadence Virtuoso Schematic Composer at 1.5V. In this paper, different adder logic styles have been implemented, simulated, analyzed and compared. Using the adder categorization and hybrid-CMOS design style, many full adders were conceived. The characteristics of the adder circuits are compared against previous designed adders based on the average power consumption, propagation delay and PDP. The research efforts of the past years in the field of digital electronics have been directed towards the low power of digital systems. The improvement in battery performance indicates power dissipation is one of the most critical parameter. Hence three most widely accepted parameters to measure the quality of a circuit or to compare various circuit styles are transistor count, propagation delay and power

dissipation. There are three major sources of power consumption in digital CMOS circuits, which are summarized in the following equation (1):-

$$P_{total} = P_{switching} + P_{short circuit} + P_{leakage}$$

$$= (\alpha_{0\to 1} \times C_L \times V_{dd}^2 \times f_{clk}) + (I_{sc} \times V_{dd}) + (I_{leakage} \times V_{dd})$$

(1)

The first term represents the switching component of power, where C is the load capacitance,  $f_{clk}$  is the clock frequency and  $\alpha_{0\rightarrow 1}$  is the node transition activity factor. The second term is due to the direct path short circuit currents, where  $I_{sc}$ , is the short circuit current which arises when both the NMOS and PMOS transistors are simultaneously active, conducting current directly from supply to ground. Finally, leakage current,  $I_{leakage}$ , which can arise from substrate injection and sub threshold effects, is primarily determined by fabrication technology considerations. However, supply voltage reduction is the most effective way to reduce the power consumption, such a reduction requires new design methods for low-voltage and low power integrated circuits. Since an average of 15-20% of the total power is dissipated in glitching, low power can also be achieved by reducing the glitches of the circuit. The deep submicron devices gives CMOS VLSI design a great chance to operate at higher speed, especially for digital signal processing. In our study, novel designs for a full adder has been proposed and authenticated. All nodes in the proposed full adders have a full-voltage swing and there is no static short-circuit current problem.

A brief overview of the various CMOS style full adder circuits is discussed below:-

# 1.1. Conventional CMOS Style Full Adders

The complementary CMOS full adder (C-CMOS) is shown in the Fig. 1. C-CMOS generates carry throughout a single static CMOS gate. The complementary CMOS logic circuit has various advantages of layout regularity and stability at low voltage due to the complementary transistor pairs and smaller count of interconnecting wires.

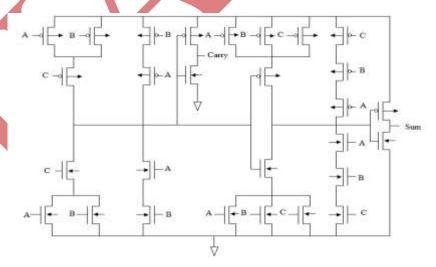


Fig. 1 C-CMOS Full Adder Cell

#### 1.2. Hybrid Style Full Adders

Some adder design styles use more than one logic style for their implementation. This is known as the Hybrid-CMOS logic design style. Hybrid full adder is shown in Fig. 2. which is designed with pass logic circuit which cogenerates the intermediate XOR and XNOR and improves the outputs. This full-adder cell works at low

supply voltage. It uses 26 transistors but has the full swing logic, balanced output and an efficient output drivability. All hybrid designs use the best available modules which are implemented using different logic styles and enhance those available modules in order to build a low power full-adder cell.

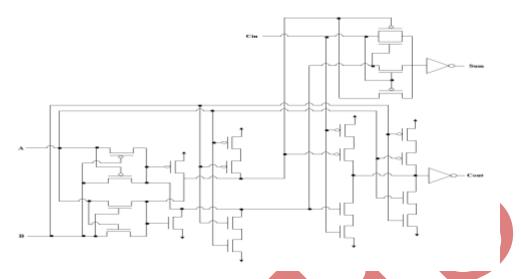


Fig. 2 Hybrid Full Adder Cell

# 1.3. Bridge Style CMOS Full Adder

In conventional CMOS design style, various realizations are obtained through organized branches, providing paths from supply lines to output whereas in bridge design style every two adjacent meshes are bridged by a transistor as shown in Fig. 3. Bridge transistors make it possible to create a new path from supply lines to an output through sharing transistors of different paths. These transistors are arranged in such a way that it validates the correctness of the circuit, and also preserves pull-up and pull-down networks mutually exclusive. In this style, control signals can be applied to the sides of meshes. The inputs must be applied to the gates of bridge transistors such as to obviate the possibility of simultaneous activation of two bridge transistors.

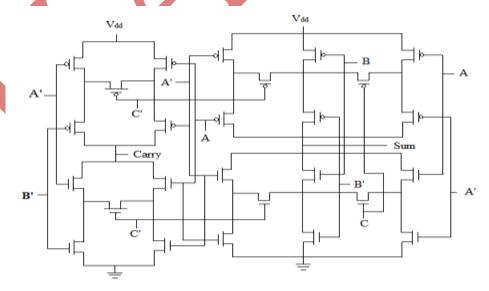


Fig. 3 Bridge Full Adder Cell

# II. PROPOSED WORK

Saradindu Panda, N. Mohan and C.K. Sarkar implemented a new adder design style with reduced transistor count from 28 to 18. Now, the designed circuit in our proposed work is implemented with 16 transistors, with

reduced Power Dissipation from the previous circuits with optimized channel length and width of NMOS and PMOS transistors.

The below circuit in the previous base paper [9] produces very high power dissipation and propagation delay, but the circuits re-designed in our proposed work after the optimization of channel length and width produces less power dissipation and propagation delay as compared to the previous base paper results.

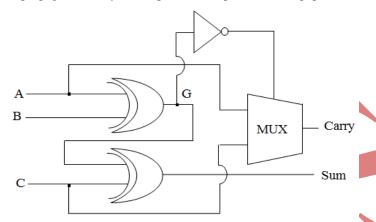


Fig. 4 Schematic Of Full Adder Circuit

Adder is the most commonly used arithmetic block of the CPU and DSP, therefore its performance and power optimization is of utmost importance. For arithmetic applications, following three different logic styles are used for a full adder design to achieve best performance results for adder design. In the proposed work, following three types of the adder circuits have been designed:-

- 1. Ripple Carry Adder
- 2. Carry Look-ahead Adder
- 3. Carry Bypass Adder

Now, the brief description of the above mentioned adders is explained below :-

# 2.1. Ripple Carry Adder

In the Fig. 5, the block diagram of ripple carry adder. Here, the full adder is built by 18 transistors by using TG technology [1]. In this circuit design process, all simulations are run using Micron Technology's 0.18 µm process models with typical n-channel and p-channel drive, a 1.8 V power supply. In the schematics, all logic styles are designed using a different gate width for NMOS and PMOS and a minimum length of 0.18 µm for NMOS and PMOS. With the help of below block diagram 8-bit ripple carry adder is developed. In the circuit there are three inputs A, B, C and two outputs sum and carry.

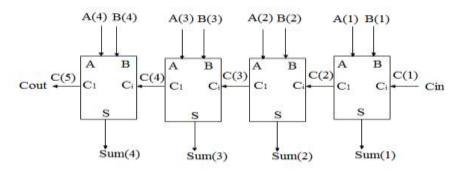


Fig. 5 Block Diagram Of Ripple Carry Adder

#### 2.2. Carry Look-ahead Adder

In the Fig. 6, the block diagram of carry look ahead adder is shown. Amita and Mrs. Nitin Sachdeva implemented the carry look-ahead adder, built by 30 transistors by using TG technology. In this circuit design process all the simulations are run using Micron Technology's 0.18  $\mu$ m process models with typical n-channel and p-channel drive, a 1.8 V power supply. In the schematics all logics are designed using a different gate width for NMOS and PMOS and a minimum length of 0.18  $\mu$ m for NMOS and PMOS. With the help of below block diagram 8-bit carry look-ahead adder is developed. In the circuit there are three inputs and two outputs.

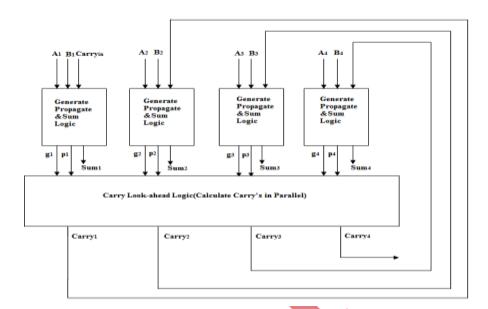


Fig. 6 Block Diagram Of Carry Look-Ahead Adder

# 2.3. Carry Bypass Adder

In the Fig. 7, the block diagram of carry bypass adder is shown. Amita and Mrs. Nitin Sachdeva implemented the 2-bit carry bypass adder by 60 transistors by using TG technology. In this design process all simulations are run using Micron Technology's  $0.18~\mu m$  process models with typical n-channel and p-channel drive, at 1.8~V power supply. In the schematics, all logics are designed using a different gate width for NMOS and PMOS and a minimum length of  $0.18~\mu m$  for NMOS and PMOS. With the help of below block diagram, 8-bit carry bypass adder is developed. In the circuit there are three inputs A, B, C and two outputs sum and carry.

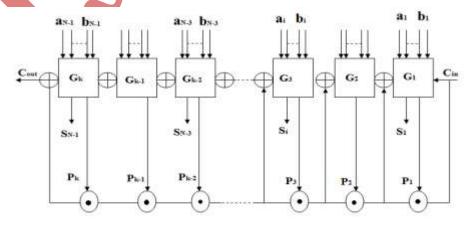


Fig. 7 Block Diagram Of Carry Bypass Adder

#### III. SOLUTIONS AND METHODOLOGY

The comparison in our proposed work has been carried out both by considering the circuits with minimum transistor count, to minimize the power consumption, and with transistors sized by optimized channel length and width. Power consumption is a function of load capacitance, frequency of operation, and supply voltage. A reduction of any one of these is beneficial. A reduction in power consumption provides several benefits. Less heat is generated, which reduces problems associated with high temperature, such as the need for heat sinks. The minimization of the two parameters i.e. the Average Power Consumption and Propagation Delay are the main objectives for designing the RCA, CLA and CBA circuits. Therefore, by optimizing the parameters and with the use of algorithms led to achieve the required simulation waveforms.

#### 3.1. Algorithm Used

- Select the 180 nm technology.
- Specify the desired transient range of the desired waveforms to be displayed.
- Mention all the specified inputs and the outputs of the designed circuit.
- Calculate the average power consumption by the coinciding point of Vdd and ground.
- Measure the delay by assigning a specific value of trigger and target.

#### 3.2. Parameter Tuning

With the use of 180 nm technology, the channel length of all the desired circuits is fixed i.e.  $0.18\mu m$  as the standard reference value. Now, in order to fix the value for the channel widths of both NMOS and PMOS transistors we calculate  $\beta$ ,

where  $\beta = (\text{channel length } / 2)$ 

Hence, 
$$\beta = (0.18/2) = 0.09 \, \mu \text{m}$$

W NMOS = 
$$3 \times \beta$$
 and, W PMOS =  $3 \times W$  NMOS

$$= 3 \times 0.09$$
  
= 0.27 \text{ \text{µm}}  
= 0.81 \text{ \text{µm}}

Hereby, setting the above mentioned values of channel length and width of NMOS and PMOS transistors, as the starting limit and varying the widths of NMOS and PMOS transistors within a specific range as listed:

$$0.27 \ \mu m \le W \ NMOS \le 0.97 \ \mu m$$
 and,  $0.81 \ \mu m \le W \ PMOS \le 2.0 \ \mu m$ 

Therefore, by varying both WNMOS and WPMOS within the above assigned limits, the final optimized parameters are obtained which corresponds to the best results with minimized power dissipation and propagation delay.

# 3.3. Optimized Parameters (for 1-bit Adder Cell) :-

Channel Length =  $0.18 \mu m$ 

Width of NMOS =  $0.64 \mu m$ 

Width of PMOS =  $1.7 \mu m$ 

With referenced voltage Vdd = 0.8V

# 3.4. Optimized Parameters (for 8-bit Adder Circuits):-

International Journal of Advanced Technology in Engineering and Science www.ijates.com Volume No.02, Issue No. 10, October 2014 ISSN (online): 2348 – 7550

Channel Length =  $0.18 \mu m$ 

Width of NMOS =  $0.8 \mu m$ 

Width of PMOS =  $2.1 \mu m$ 

With referenced voltage Vdd = 1.2V

Below tables depicts the optimized performance parameters of the adders:-

Table I
Performance Parameters Of 1 Bit Adder

Table II
Performance Parameters Of 8 Bit Adders

Software Used	Adder Type	Transistor Count	Avg. Power Dissipation (µW)	Propagation Delay at Carry (ns)
TANNER EDA Tool	Single Bit Adder	16	0.6	0.06

Software Used	Adder Type	Transistor Count	Avg. Power Dissipation (mW)	Propagation Delay at Carry (ns)
TANNER	RCA	146	0.041	0.016
EDA Tool	CLA	240	0.089	0.016
	CBA	240	0.086	0.015

### IV. RESULTS

The results of different 8-bit adders have been obtained in terms of propagation delay and power dissipation. Delay is an important parameter in adders. The delay during sum and carry operation determines the speed of SRAM, and this is important in high speed application. It can be calculated by using horizontal lines and vertical lines in EDA TANNER tool. Vertical and horizontal lines are used to find the accurate value of delay. From the above TABLE 1 and TABLE 2, the Average Power Dissipation of RCA is 0.041 mW, but the average power dissipation of CLA and CBA is 0.089 mW and 0.086 mW respectively. Therefore, the RCA has the least average power dissipation as compared to CLA and CBA. The Propagation Delay of RCA is 0.016 ns and that of CLA is also 0.016 while CBA has 0.015 ns delay. Therefore, the CBA has the least propagation delay as compared to the RCA and CLA. The Transistor Count of RCA is 146, but that of CLA and CBA is 240 each. Therefore, it clearly indicates that number of transistors in CLA and CBA are almost double than that of RCA, but even then due to the better design style, all three have an equivalent Power Dissipation. Hereby in RCA, the adder designed with the least Transistor Count and minimized area results in achieving the minimum average power dissipation.

Table III
Comparative Analysis Of Performance
Parameters Of 1- Bit Adder

Table IV Comparative Analysis Of Performance Parameters Of 8- Bit Ripple Carry Adder

Algorithm	Software Used	Single Bit Adder			
Туре		Transistor Count	Avg. Power Dissipation (µW)	Propagation Delay at Carry (ns)	
S. Wairya et al.[9]	CADENCE TOOL	16	4.14	0.018	
Proposed Algorithm	TANNER EDA TOOL	16	0.6	0.06	

Algorithm	Software Used	Ripple Carry Adder			
Type		Transistor Count	Avg. Power Dissipation (mW)	Propagation Delay at Carry (ns)	
R.UMA et al.[10]	MICROWIND TOOL	288	0.206	4.208	
Proposed Algorithm	TANNER EDA TOOL	146	0.041	0.016	

Table V Comparative Analysis Of Performance Parameters Of 8-Bit Carry Look-Ahead Adder

Algorithm	Software Used	Carry Look-ahead Adder			
Туре		Transistor Count	Avg, Power Dissipation (mW)	Propagation Delay at Carry (ns)	
R.UMA et aL[10]	MICROWIND TOOL	272	0.312	3.1	
Proposed Algorithm	TANNER EDA TOOL	240	0.089	0.016	

Table VI Comparative Analysis Of Performance Parameters Of 8-Bit Carry Bypass Adder

Algorithm	Software Used	Carry Bypass Adder			
Туре		Transistor Count	Avg, Power Dissipation (mW)	Propagation Delay at Carry (ns)	
R.UMA et al.[10]	MICROWIND TOOL	372	0.459	3.01	
Proposed Algorithm	TANNER EDA TOOL	240	0.086	0.015	

The simulations represents for an adder cell as well as different 8 bit adders are obtained in TANNER tool in the following section with A, B, C as inputs and Sum, Carry as outputs.

#### 4.1. Waveforms Of 1- Bit Adder Cell

# 4.2. Waveforms Of 8-Bit Ripple Carry Adder

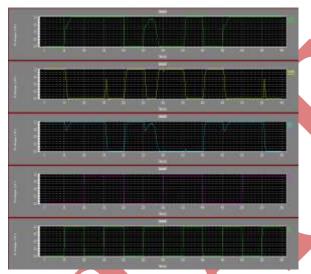


Fig. 8 Waveforms Of Single Bit Adder

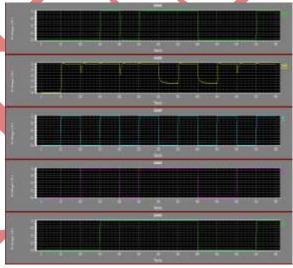


Fig. 9 Waveforms Of 8- Bit Ripple Carry Adder 4.4. Waveforms Of 8-Bit Carry Bypass Adder

# 4. 3. Waveforms Of 8-Bit Carry Look-Ahead Adder



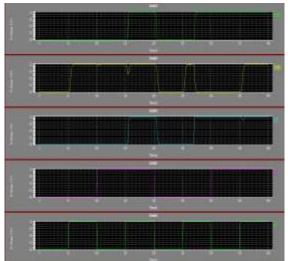


Fig. 10 Waveforms Of 8-Bit Carry Look -Ahead Adder Fig. 11 Waveforms Of 8- Bit Carry Bypass Adder

#### V. CONCLUSIONS

In this proposed work, the comparative performance analysis of the 1- bit full adder cell with 180 nm technology has been carried out. The comparison has been performed on average power dissipation, propagation delay and transistor count. The performance analyses, waveforms showing simulation results and comparison have been depicted in Section III and Section IV. The achieved results reveal that there is an enormous decrease in the average power dissipation in the proposed circuit. However, the transistor count remains the same with an approximately equivalent propagation delay at carry, when compared with the research efforts of the past years. Similarly, the performance parameters in case of all the 8- bit full adders i.e. RCA, CLA and CBA when compared, reveals that there is a huge reduction in all the three parameters i.e. transistor count, average power dissipation and propagation delay. Thus, the result indicates that CBA is the fastest full adder topology with minimum propagation delay even with maximum transistor count amongst RCA, CLA and CBA. Hereby it is concluded that average power dissipation and propagation delay in TG based adders are very less as compared to conventional CMOS and other circuits. Therefore, it is concluded that RCA consumes the minimum power due to least number of transistors used in the circuit design. Even the Propagation Delay of RCA is almost comparable with CLA and CBA, and with minimum Average Power Dissipation RCA is the best amongst all.

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